



Power MOSFETS

DATASHEET

LM20400PLI3A

P-Channel
Enhancement Mode MOSFET

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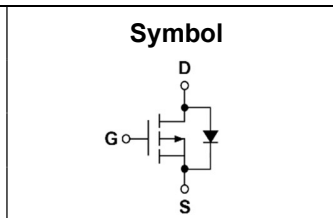
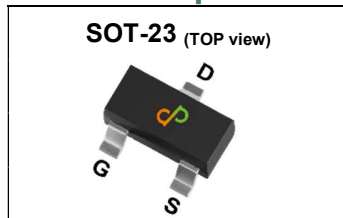
Quality Management Systems

ISO 9001:2015 Certificate

LM20400PLI3A

P-Channel Enhancement Mode MOSFET

Pin Description



Ordering Information

Symbol	P-Channel	Unit
V_{DSS}	-20	V
$R_{DS(ON)-Max}$	43	mΩ
I_D	-4.3	A

Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free

Applications

- Portable Equipment
- Battery Powered System

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM20400PLI3A	SOT-23	Tape & Reel	3000 / Tape & Reel	08□□□

Note : □□□ = Lot Code

Absolute Maximum Ratings ($T_J=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter		P-Channel	Unit
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±8	
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to 150	°C
I _{DM} ^①	Pulse Drain Current Tested	T _A =25°C	-10.8	A
I _D	Continuous Drain Current	T _A =25°C	-4.3	A
		T _A =70°C	-3.5	
P _D	Maximum Power Dissipation	T _A =25°C	1.1	W
		T _A =70°C	0.7	
I _{AS} ^②	Avalanche Current, Single pulse	L=0.1mH	-11	A
E _{AS} ^②	Avalanche Energy, Single pulse	L=0.1mH	6	mJ

Thermal Characteristics

Symbol	Parameter		Rating	Unit
R _{θJA} ③	Thermal Resistance-Junction to Ambient	Steady State	110	°C/W

Note ① : Max. current is limited by junction temperature.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.

P-Channel Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =-250uA	-20	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-16V, V _{GS} =0V	-	-	-1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =-250uA	-0.35	-0.6	-0.85	V
I _{GSS}	Gate Leakage Current	V _{GS} =±8V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^④	Drain-Source On-state Resistance	V _{GS} =-4.5V, I _{DS} =-4A	-	36	43	mΩ
		V _{GS} =-2.5V, I _{DS} =-4A		45	59	
		V _{GS} =-1.8V, I _{DS} =-2A	-	56	84	
gfs	Forward Transconductance	V _{DS} =-5V, I _{DS} =-2.8A	-	11.6	-	S
Dynamic Characteristics ^⑤						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, Freq.=1MHz	-	16	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-10V, Freq.=1MHz	-	933	-	pF
C _{oss}	Output Capacitance		-	96	-	
C _{rss}	Reverse Transfer Capacitance		-	83	-	
td(ON)	Turn-on Delay Time	V _{GS} =-4.5V, V _{DS} =-10V, I _D =-1A, R _{GEN} =6Ω	-	7.2	-	nS
t _r	Turn-on Rise Time		-	13.4	-	
t _{d(OFF)}	Turn-off Delay Time		-	26	-	
t _f	Turn-off Fall Time		-	17	-	
Q _g	Total Gate Charge	V _{GS} =-4.5V, V _{DS} =-10V, I _D =-5A	-	6.8	-	nC
Q _{gs}	Gate-Source Charge		-	0.8	-	
Q _{gd}	Gate-Drain Charge		-	2.5	-	
Source-Drain Characteristics						
V _{SD} ^④	Diode Forward Voltage	I _{SD} =-1.2A, V _{GS} =0V	-	-0.65	-1.1	V
t _{rr}	Reverse Recovery Time	I _F =-5A, V _R =-10V	-	18	-	nS
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/μs	-	7	-	nC

Note ④ : Pulse test (pulse width≤300us, duty cycle≤2%).

Note ⑤ : Guaranteed by design, not subject to production testing.

P-Channel Typical Characteristics

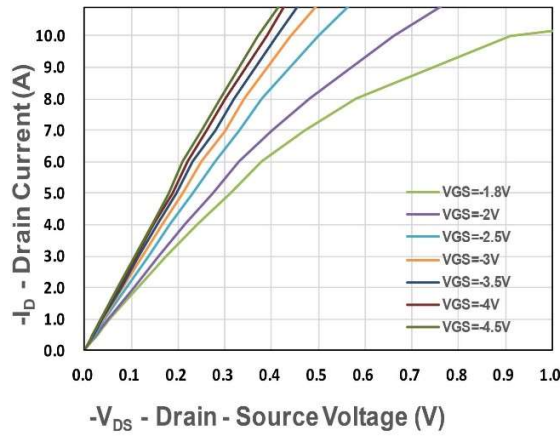


Figure 1. Output Characteristics

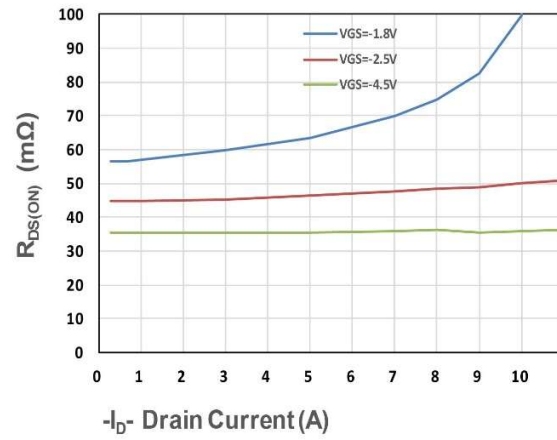


Figure 2. On-Resistance vs. ID

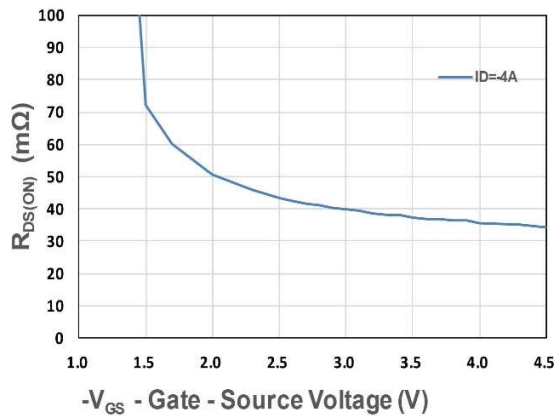


Figure 3. On-Resistance vs. VGS

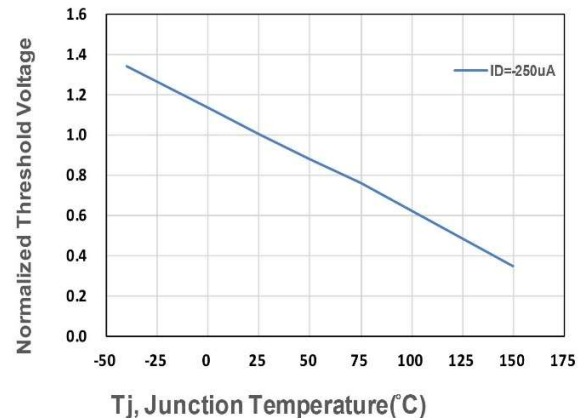


Figure 4. Gate Threshold Voltage

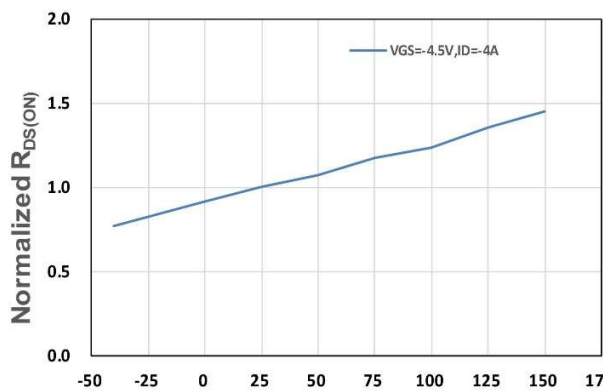


Figure 5. Drain-Source On Resistance

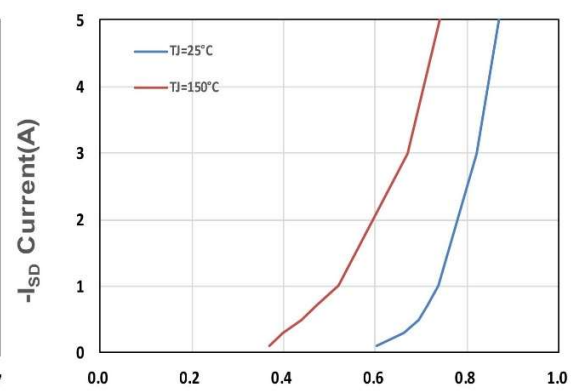


Figure 6. Source-Drain Diode Forward

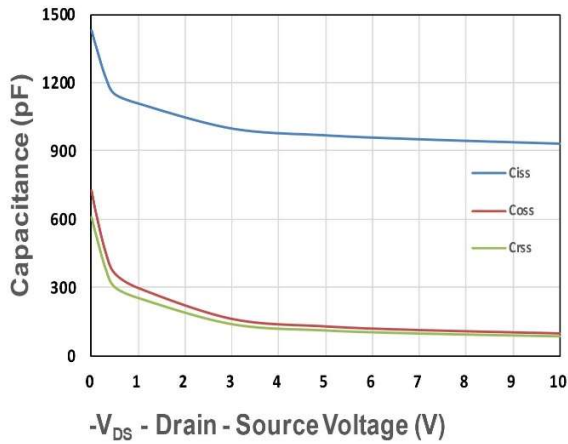


Figure 7. Capacitance

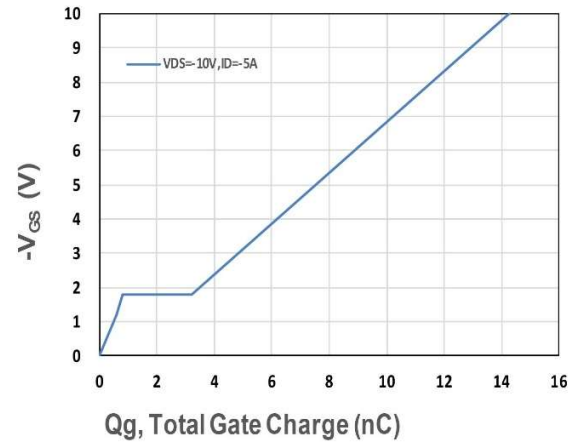


Figure 8. Gate Charge Characteristics

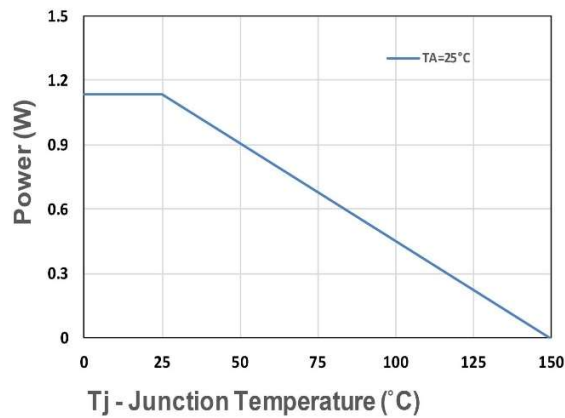


Figure 9. Power Dissipation

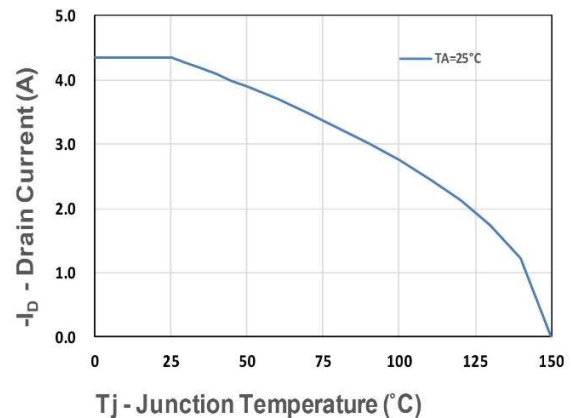


Figure 10. Drain Current

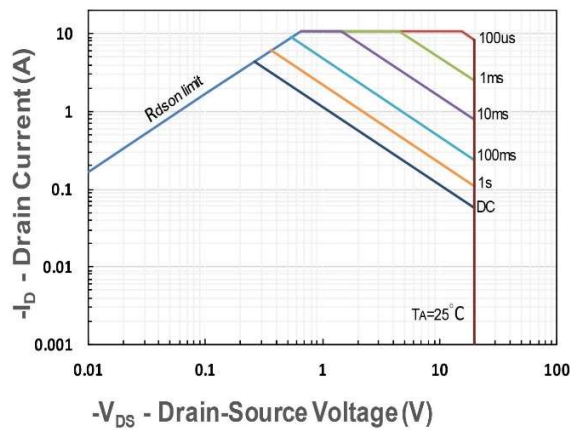


Figure 11. Safe Operating Area

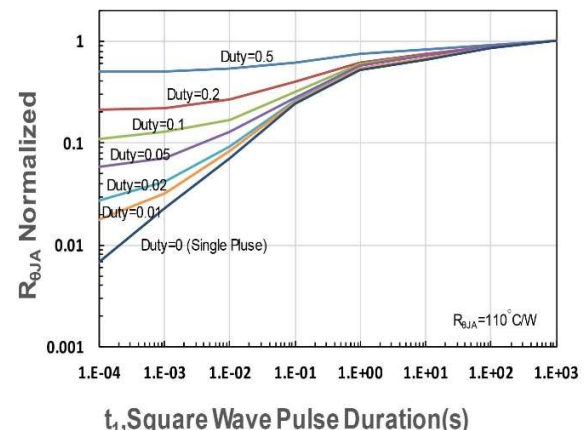


Figure 12. $R_{\theta JA}$ Transient Thermal Impedance